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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce, Patent and Trademark Office	Attorney's Docket No. 07206-047001	Application No. 09/504,660			
by A _l	closure Statement	Applicant William E. Hoke et al.				
(Use several sh (37 CFR §1.98(b))	neets if necessary) Jun '	February 14, 2000	Group Art Unit 2871			

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Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate				
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Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
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	Other Documents (include Author, Title, Date, and Place of Publication)										
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Examiner Signature	Date Considered 10/3/0)
EXAMINER: Initials citation considered. Draw line through citation if no next communication to applicant.	ot in conformance and not considered. Include copy of this form with

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OIF	INFORMATION DISCLOSURE CITATION (Use squared sheets if necessary)										APPLICANT William E. Hoke et al.					
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0~		*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in														

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